

ARB RIDER

Time to **Reinvent** advanced signal generation

AWG-4010 SERIES Technical Datasheet



2 / 4 / 8 CHANNELS – ALL IN ONE: Function Generator, Arb Generator, Serial Pattern Generator and Digital Pattern Generator

- 2, 4 or 8 Analog Channels
- **1.2 GS/s 16 Bit** Vertical Resolution
- 300 MHz Bandwidth (300 Mbaud for Data Pattern Generator)
- Up to **24 V_{p-p}** Output Voltage and $\pm 12V$ HW Baseline Offset
Total Output Voltage Window $\pm 24V$ (48 V_{p-p}) into High Impedance
- Up to **1Gpts** Waveform Memory per Channel
- Up to 32 Digital Channels in synchronous with analog Generation
- Simple Rider™ UI: designed for touch AWG/AFG/SPG user interfaces

Key performance specifications

- **AFG Mode**
 - 300 MHz Sine Waveforms
 - 1.2 GS/s fixed, 16-bit vertical resolution
 - Amplitude up to 12 V_{p-p} into 50 Ω load
 - Programmable hardware offset: $\pm 6V$ into 50 Ω
 - Improved DDS based technology
- **AWG Mode**
 - 1.2 GS/s Variable Clock, 16-bit vertical resolution
 - 8 bit, 16 bit or 32 bit digital channels
 - Up to 1 Gpts Waveform Memory per Channel
 - 318 MHz Calculated Bandwidth
 - Amplitude up to 12 V_{p-p} into 50 Ω load
 - Programmable hardware offset: $\pm 6V$ into 50 Ω
- **Serial Pattern Generator (SPG) Mode - *Optional***
 - Up to 300Mbit/s NRZ bit stream generation
 - 2, 3 or 4 levels
 - 64 points arbitrary shape per transition
 - Programmable duration for any transition
 - Up to 2Mbit (2 levels) or up to 1MSymbols (3 or 4 levels) pattern memory for channel
 - Amplitude up to 12 V_{p-p} into 50 Ω load
 - Programmable hardware offset: $\pm 6V$ into 50 Ω

Features & Benefits

- Sample rate can be programmed in from 1 S/s to 1.2 GS/s, with 16-bit vertical resolution, ensures exceptional signal integrity
- Arbitrary waveform memory up to 1Gpts for each analog channel
- Mixed Signal Generation – 2, 4 or 8 Analog channels with 8, 16 or 32 synchronized Digital Channels for debugging and validating digital design
- Three operation modes – Simple Rider AFG (DDS AFG mode), True Arb (variable clock Arbitrary AWG mode) and SPG (Serial Pattern Generator - *Optional*)
- Digital outputs provide up to 1.2 Gb/s data rate in LVDS format. LVDS to LVTTTL adapter is available
- Advance sequencer with up to 16384 user defined waveforms provides the possibility of generating complex signal scenarios with the most efficient memory usage
- Windows based platform with 7in touch screen, front panel buttons and knob
- Compact form factor, convenient for bench top and fully fit with 3U – 19" rackmount standard
- LAN, USB-TMC and GPIB interfaces for remote control

Applications areas

Automotive



Today's cars are including a lot of highly sophisticated electronic control unit with very sensitive high technology electronic components.

The Arb Rider 4012/4014/4018 combining 1.2 GS/s with 16 bit vertical resolution, represents an ideal tool for successfully addressing the new testing challenges in automotive.

- CAN, CAN-FD, LIN, Flexray, SENT emulation
- EMI debugging, troubleshooting and testing
- Electrical standards emulation up to 24V
- Power MOSFET circuitry in automotive electronics optimization

IoT and Ind 4.0 perfect RF Modulator



Arb and Function Riders will be the iconic instrument for these applications. The possibility to emulate complex RF I/Q modulation for simulation and Test vs wireless devices or working on Internet of things of industry 4.0 applications. Each engineer may use the possibility to import waveform to emulate devices under test, impose distortion on waveform (such noise) to test the ability of devices to be compliant to the standards.

Research Applications

Research centers and Universities, are key users of Arb Rider generators's series.

Complex waveform and/or sophisticated Pulses emulation based on variable edges or multilevel could be perfectly created. The combination of fast edge generation, excellent dynamic range and easy to use user interface meet perfectly scientists and engineers working on large experiments such Accelerators, Tokamak or synchrotrons to emulate signals without creating specifics test boards.

- Emulation of detectors
- Emulation of signal sources adding noise
- Generation/playback of real-world signals
- Emulation of long PRBS sequences
- Modulating and driving laser diode

Aerospace and Defense applications

Electronic warfare signals driven by Radar or Sonar systems perfectly match with these generators. Large BW Riders can be used on digital modulation systems for Radio Applications or others I/Q signal modulation.

Pulses may be easily generated for applications such Pulse Electron Beam or X Ray Sources, Flash X-ray Radiography, Lighting pulse simulators, high Power Microwave modulators.

- Frequency response, intermodulation distortion and noise-figure measurements
- Phase Locked Loop (PLL) pull-in and hold range characterization
- Radar base-band signals emulation

Semiconductors Test

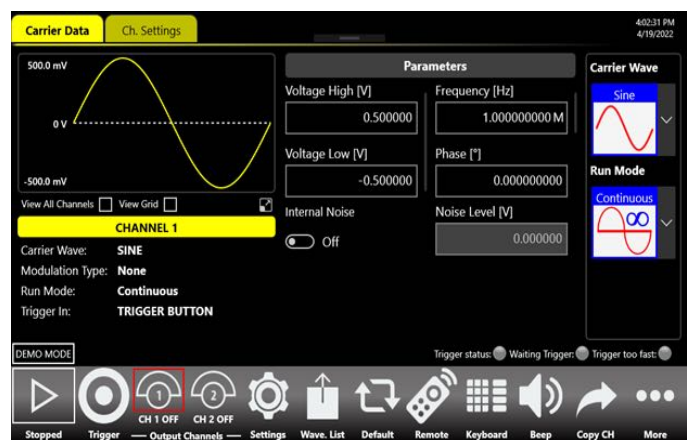
Emulation of complex signals generated with inclusion of noise or distortions may became an excellent way to provide Compliance Components Test to help semiconductors engineers. The fast edges and pulse generation can be used to provide characterization in fast power devices.

- Clock and Sensor signals generation
- MOSFET gate drive amplitude signal emulation
- Power up sequences of IC using the low impedance feature (5 Ω output impedance)

Simple Rider AFG: Function Generator Mode Interface

Simple Rider AFG UI is designed for touch and it has been developed to put all the capabilities of modern Waveform Generators right at your fingertips. All instrument controls and parameters are accessed through an intuitive UI that recalls the simplicity of Tablets and modern smart phones: touch features and gestures are available to engineers and scientists to create advanced waveforms or digital patterns in few touches.

- The swipe gesture gives easy access to the output waveform parameters
- A touch-friendly virtual numeric keypad has been designed to improve the user experience on entering



the data.

- Time saving shortcuts and intuitive icons simplify the instrument setup

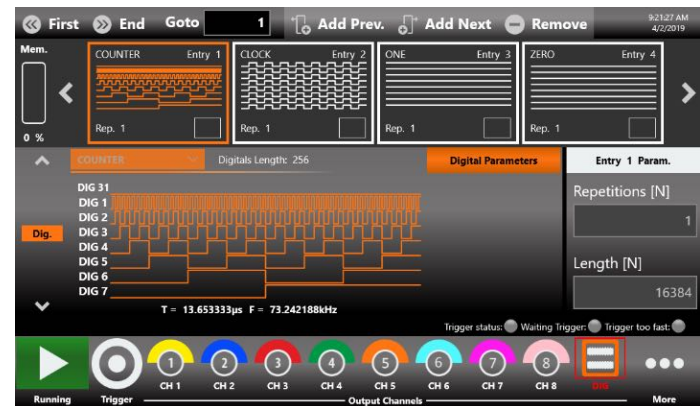
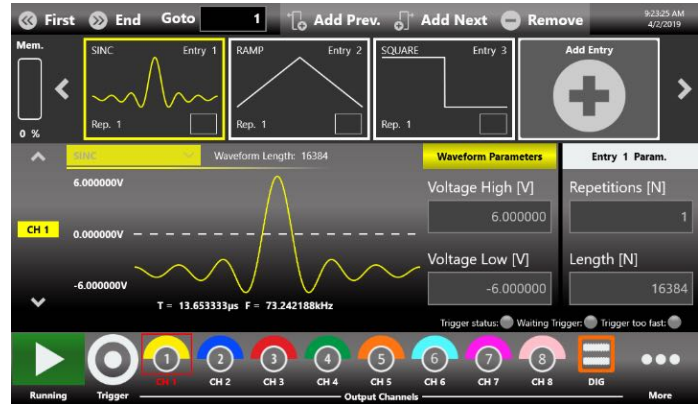
Simple Rider TrueArb: AWG Mode Interface

In **Simple Rider True-Arb** interface, the users can define complex waveforms with up to 16,384 sequence entries of analog waveforms and digital patterns, define their execution flow by means of loops, jumps and conditional branches.

Digital output combined and synchronized with analog output signals represent an ideal tool to troubleshoot and validate digital design. The waveform memory length of up to 1 GSamples on each channel combined with up to 16,384 and up to 4,294,967,294 repetitions, make the Arb-Rider 4012/4014/4018 the ideal generator for the most demanding technical applications.

Thanks to the intuitive and easy waveform sequencer user interface, the most complex waveform scenarios can be created with just few screen touches.

Up to 4 instruments can be synchronized together in order to obtain a 32 analog – 128 digital channel generator. A dedicated synchronization bus guarantees the intra-chassis synchronization. This feature is available on AWG4018 model only Arb Rider supports the standard Ethernet interface for remote control and easy customized instrument programming.



Simple Rider SPG: Serial Pattern Generator (SPG) Mode Interface – *Optional*

The easiest touch screen display interface allows to create patterns scenarios, only in a few screen touches.


In summary the Data Pattern Generator provides the capability to generate PRBS patterns and up to 2MSymbols custom patterns where bit transitions can have arbitrarily user defined shapes. The ARB-RIDER-AWG4010 Serial Pattern Generator can generate patterns up to 300Mbaud.



The software architecture provides the possibility to easily generate the patterns in different generation modality and also gives the opportunity to modulate the patterns with internal or external signals with the purpose to generate also different effects of noise (jitter, ripple, ...).

All specifications are typical unless noted otherwise. The guaranteed performances are referred to a calibrated instrument that has been stored for a minimum of 2 hours within the operating temperature range of 5°C to 40°C and after a 45-minute warm up period. Within $\pm 10^\circ\text{C}$ after auto-calibration.

Some specifications on this document refer to the available options and accessories that can be found in the table at the end of this document.

General Specifications			
Number of Channels	AWG - 4012	AWG - 4014	AWG - 4018
			
Analog out / DPG out	2	4	8
Digital out	0/8 optional	0/8/16 optional	0/8/16/32 optional
Marker out	1	2	4
Operating Mode	AFG Mode True Arb Mode Serial Pattern Generator (Optional)		
Amplitude			
Range (50 Ω into 50 Ω) ¹	0 to 6Vpp (12 V _{p-p} optional)		
Accuracy (1kHz sine wave, 0V offset, > 5mV _{p-p} amplitude, 50 Ω load) (guaranteed)	$\pm(1\% \text{ of setting } [V_{p-p}] + 5 \text{ mV})$		
Resolution	<0.5 mV _{p-p} or 5 digits		
Output impedance	Single-ended: 50 Ω , Low Impedance: 5 Ω		
Baseline Offset			
Range (50 Ω into 50 Ω)	-3 V to +3 V (-6V to +6V opt.)		
Range (50 Ω into High Z load)	-6 V to +6 V (-12V to +12V opt.)		
Accuracy (50 Ω into 50 Ω) (guaranteed)	$\pm(1\% \text{ of } \text{setting} \pm 5 \text{ mV})$		
Resolution	<4 mV or 4 digits		

¹ Amplitude doubles on HiZ load

DC	
Amplitude range (50 Ω , single-ended)	-3V to 3V (-6V to 6V opt.)
Amplitude accuracy (guaranteed)	$\pm(1\% \text{ of } \text{setting} + 10 \text{ mV})$
AFG Mode Specifications	
Output Channels	
Connectors	BNC on front panel
Output type	Single-ended
Output Impedance	50 Ω or 5 Ω (low impedance)
General Specifications	
Operating mode	DDS mode
Standard Waveforms	Sine, Square, Pulse, Ramp, more (Noise, DC, Sin(x)/x, Gaussian, Lorentz, Exponential Rise, Exponential Decay, Haversine)
Run Modes	Continuous, modulation, sweep, burst
Arbitrary Waveforms	Vertical resolution: 16-bit Waveform length: 16,384 points
Internal Trigger Timer	
Range	
Resolution	13.3 ns to 100 s
Accuracy	104 ps $\pm(0.1\% \text{ setting} + 5 \text{ ps})$
Sine Waves	
Frequency Range Sine (50 Ω into 50 Ω) ²	1 μHz to $\leq 70 \text{ MHz}$: 12V >70 MHz to $\leq 120 \text{ MHz}$: 9V >120 MHz to $\leq 180 \text{ MHz}$: 6V

² Amplitude doubles on HiZ load

<p>Flatness (1 V_{p-p}, relative to 1 kHz)</p> <p>Harmonic Distortion (1 V_{p-p})</p> <p>Total Harmonic Distortion (1 V_{p-p})</p> <p>Spurious (1 V_{p-p}) (excluding f_{Sa} - f_{out}, f_{Sa} - 2*f_{out})</p> <p>Phase Noise (1 V_{p-p}, 10 kHz offset)</p>	<p>> 180 MHz to ≤ 300 MHz: 3V (without HV opt. the maximum amplitude is limited to 6 V)</p> <p>DC to 300 MHz: ±0.5 dB</p> <p>1 μHz to ≤ 10 MHz: < -65 dBc > 10 MHz to ≤ 50 MHz: < -55 dBc > 50 MHz to ≤ 100 MHz: < -45 dBc > 100 MHz to ≤ 300 MHz: < -30 dBc</p> <p>10 Hz to 20 kHz: < 0.1%</p> <p>1 μHz to ≤ 10 MHz: < -60 dBc > 10 MHz to ≤ 300 MHz: < -55 dBc</p> <p>10 MHz: < -120 dBc/Hz typ. 100 MHz: < -115 dBc/Hz typ.</p>
<p>Square Waves</p> <p>Frequency Range</p> <p>Rise/fall time</p> <p>Overshoot (1 V_{p-p})</p> <p>Jitter (rms)</p>	<p>1 μHz to ≤ 40 MHz: 12V > 40 MHz to ≤ 80 MHz: 10V > 80 MHz to ≤ 150 MHz: 7V (without HV opt. the maximum amplitude is limited to 6 V)</p> <p>2 ns < 2% < 20 ps</p>

<p>Pulse Waves</p> <p>Frequency Range</p> <p>Pulse width</p> <p>Pulse width Resolution</p> <p>Pulse Duty Cycle</p> <p>Leading/trailing edge transition time</p> <p>Transition time Resolution</p> <p>Overshoot (1 V_{p-p})</p> <p>Jitter (rms, with rise and fall time ≥ 2ns)</p>	<p>1μHz to ≤ 5 MHz: 12V</p> <p>>5 MHz to ≤60 MHz: 10V</p> <p>>60 MHz to ≤150 MHz: 7V</p> <p>(without HV opt. the maximum amplitude is limited to 6 V)</p> <p>2.5 ns to (Period – 2.5 ns)</p> <p>20 ps or 15 digits</p> <p>0% to 100%, 14 digits</p> <p>(limitations of pulse width apply)</p> <p>2 ns to 1000 s</p> <p>2 ps or 15 digits</p> <p>< 2%</p> <p><20 ps</p>
<p>Double Pulse Waves</p> <p>Frequency Range</p> <p>Other Pulse Parameters</p>	<p>Without HV option :</p> <p>1μHz to ≤ 5 MHz: 12 V_{p-p}</p> <p>>5 MHz to ≤100 MHz: 6 V_{p-p}</p> <p>where V_{p-p} = V_{p-p} 1 + V_{p-p} 2 </p> <p>With HV option :</p> <p>1μHz to ≤ 5 MHz: 24 V_{p-p}</p> <p>>5 MHz to ≤60 MHz: 10 V_{p-p}</p> <p>>60 MHz to ≤100 MHz: 7 V_{p-p}</p> <p>where V_{p-p} = V_{p-p} 1 + V_{p-p} 2 </p> <p>Same as Pulse Waves</p>
<p>Ramp Waves</p> <p>Frequency Range</p>	<p>1 μHz to 15 MHz</p>

Linearity (< 10 kHz, 1 V _{p-p} , 100%)	≤ 0.1%
Symmetry	0% to 100%
Other Waves	
Frequency Range	
Exponential Rise, Exponential Decay	1 μHz to 15 MHz
Sin(x)/x, Gaussian, Lorentz, Haversine	1 μHz to 30 MHz
Additive Noise	
Bandwidth (-3 dB)	> 200 MHz
Level	0 V to 6 V – carrier max value [V _{pk}]
Resolution	1 mV
Arbitrary	
Number of Samples	2 to 16,384
Frequency range	1 μHz to ≤ 150 MHz
Analog Bandwidth (-3 dB)	175 MHz
Rise/fall time	2 ns
Jitter (rms)	< 20 ps
Frequency Resolution	
Sine, square, pulse, arbitrary, Sin(x)/x	1 μHz or 15 digits
Gaussian, Lorentz, Exponential Rise, Exponential Decay, Haversine	1 μHz or 14 digits
Frequency Accuracy	
Non-ARB	±2.0 x 10 ⁻⁶ of setting
ARB	± 2.0 x 10 ⁻⁶ of setting ±1 μHz

Modulations	
<p>Amplitude Modulation (AM)</p> <p>Carrier waveforms</p> <p>Modulation source</p> <p>Internal modulating waveforms</p> <p>Modulating frequency</p> <p>Depth</p>	<p>Standard waveforms (except Pulse, DC and Noise), ARB</p> <p>Internal or external Sine, Square, Ramp, Noise, ARB</p> <p>Internal: 500 μHz to 48 MHz External: 8 MHz maximum</p> <p>0.00% to 120.00%</p>
<p>Frequency Modulation (FM)</p> <p>Carrier waveforms</p> <p>Modulation source</p> <p>Internal modulating waveforms</p> <p>Modulating frequency</p> <p>Peak deviation</p>	<p>Standard waveforms (except Pulse, DC and Noise), ARB</p> <p>Internal or external Sine, Square, Ramp, Noise, ARB</p> <p>Internal: 500 μHz to 48 MHz External: 8 MHz maximum</p> <p>DC to 300 MHz</p>
<p>Phase Modulation (PM)</p> <p>Carrier waveforms</p> <p>Modulation source</p> <p>Internal modulating waveforms</p> <p>Modulating frequency</p>	<p>Standard waveforms (except Pulse, DC and Noise), ARB</p> <p>Internal or external Sine, Square, Ramp, Noise, ARB</p> <p>Internal: 500 μHz to 48 MHz</p>

Phase deviation range	External: 8 MHz maximum 0° to 360°
Frequency Shift Keying (FSK)	
Carrier waveforms	Standard waveforms (except Pulse, DC and Noise), ARB
Modulation source Internal modulating waveforms	Internal or external Square
Key rate	Internal: 500 µHz to 48 MHz, External: 8 MHz maximum
Hop frequency	1 µHz to 300 MHz
Number of keys	2
Phase Shift Keying (PSK)	
Carrier waveforms	Standard waveforms (except Pulse, DC and Noise), ARB
Modulation source Internal modulating waveforms	Internal or external Square
Key rate	Internal: 500 µHz to 48 MHz, External: 8 MHz maximum
Hop phase	0° to +360°
Number of keys	2
Pulse Width Modulation (PWM)	
Carrier waveforms	Pulse
Modulation source Internal modulating waveforms	Internal or external Sine, Square, Ramp, Noise, ARB

Modulating frequency	Internal: 500 μ Hz to 48 MHz External: 8 MHz maximum
Deviation range	0% to 50% of pulse period
Sweep	
Type	Linear, Logarithmic, staircase, and user defined
Waveforms	Standard waveforms (except Pulse, DC and Noise), ARB
Sweep time	40 ns to 2000 s
Hold/return times	0 to (2000 s – 40 ns)
Sweep/hold/return time resolution	20 ns or 12 digits
Total sweep time accuracy	$\leq 0.4\%$
Start/stop frequency range	Sine: 1 μ Hz to 300 MHz, Square: 1 μ Hz to 150 MHz
Trigger source	Internal (Timer) / External / Manual
Burst	
Waveforms	Standard waveforms (except DC and Noise), ARB
Type	Trigger or gated
Burst count	1 to 4,294,967,295 cycles or Infinite
TrueArb Mode Specifications	
Output Channels	
Connectors	BNC on front panel
Output type	Single-ended
Output Impedance	50 Ω or 5 Ω (low impedance)
General specifications	
Operating Mode	Variable clock (True Arbitrary)
Run Modes	Continuous, Triggered Continuous, Single/Burst, Stepped, Advanced

Vertical Resolution	16 bit
Waveform Length	16 to 2M samples per channel (AWG401X-2M) 16 to 64M samples per channel (AWG401X-64M) 16 to 128M samples per channel (AWG401X-128M) 16 to 1GS samples per channel (AWG401X-1G) where X = 2,4 or 8
Waveform Granularity	1 if the entry length is > 384 samples 16 if entry length is ≥ 32 and ≤ 384 samples
Sequence Length	1 to 16384
Sequence Repeat Counter	1 to 4294967294 or infinite
Timer Range	23.52 ns to 7 seconds
Timer Resolution	± 1 sampling clock cycle
Analog Channel to Channels skew	
Range	0 to 3.4 μ s
Resolution	≤ 5 ps
Accuracy	$\pm(1\%$ of setting + 20 ps)
Initial skew	< 200 ps
Calculated bandwidth (0.35 / rise or fall time)	≥ 318 MHz
Harmonic distortion (Sine wave 32 points, 1 V_{p-p})	< -60 dBc (@ 1.2 GS/s, 37.5 MHz)
Spurious (Sine wave 32 points, 1 V_{p-p})	< -60 dBc (@ 1.2 GS/s, 37.5 MHz)
SFDR (Sine wave 32 points, 1 V_{p-p})	< -60 dBc (@ 1.2 GS/s, 37.5 MHz)
Rise/fall time (1 V_{p-p} single-ended 10% to 90%)	≤ 1.1 ns
Overshoot (1 V_{p-p} single-ended)	< 2%

Timing and Clock	
Sampling Rate	
Range	1 Sample/s to 1.2 GSample/s
Resolution	16 Hz
Accuracy	$\pm 2.0 \times 10^{-6}$
Random jitter on clock pattern (rms)	< 10 ps
Digital Outputs (Optional)	
Output Channels	
Connectors	Mini-SAS HD connector on rear panel (Non-standard pin-out)
Number of connectors	1
Number of outputs	8-bits
Output impedance	100 Ω differential
Output type	LVDS
Rise/fall time (10% to 90%)	< 1 ns
Jitter (rms)	20 ps
Maximum update rate	1.2 Gbps
Memory depth	2M samples per channel (AWG401X-2M) 64M samples per channel (AWG401X-64M) 128M samples per channel (AWG401X-128M) 1G samples per channel (AWG401X-1G) where X= 2,4 or 8
Data Pattern Generator (DPG) Specifications - <i>Optional</i>	
Output Channels	
Connectors	BNC on front panel
Output type	Single-ended
Output Impedance	50 Ω or 5 Ω (low impedance)

<p>General Specifications</p> <p>Operating mode</p> <p>Pattern types</p> <p>Run Modes</p> <p>Internal Trigger Timer</p> <p> Range</p> <p> Resolution</p> <p> Accuracy</p>	<p>NRZ bitstream Pattern generator</p> <p>Clock Pattern, Custom Pattern, PRBS pattern</p> <p>Continuous, modulation, burst (Triggered, Gated, Continuous triggered)</p> <p>13.3 ns to 100 s</p> <p>104 ps</p> <p>±(0.1% setting + 5 ps)</p>
<p>Transition Specifications</p> <p>Transition peculiarity</p> <p>Transitions types</p> <p>Transitions memory length</p> <p>Predefined transition Shapes</p> <p>Transition duration[0-100%]</p>	<p>Arbitrarily user defined transition shapes</p> <p>Programmable duration for any transition</p> <p>Arbitrary, predefined</p> <p>64 points</p> <p>Sine, Square, Pulse, Ramp_up, Ramp_down, DC, Sin(x)/x, Gaussian, Lorentz, Exponential Rise, Exponential Decay, Haversine</p> <p>1.5ns to Symbol duration for Custom and PRBS pattern</p> <p>1,5ns to Period/2 for Clock Pattern</p>
<p>Clock Pattern</p> <p>Max clock pattern frequency</p> <p>Pattern levels</p> <p>Overshoot (1 V_{p-p})</p> <p>Jitter (rms)</p>	<p>150 MHz</p> <p>2 levels</p> <p>< 2%</p> <p>< 20 ps</p>

<p>Custom Pattern</p> <p>Max custom pattern rate</p> <p>Pattern levels</p> <p>Predefined custom patterns</p> <p>Pattern memory</p> <p>Pattern length resolution</p> <p>Min pattern length</p> <p>Overshoot (1 V_{p-p})</p>	<p>Up to 300 Mbaud</p> <p>2, 3 or 4 levels</p> <p>Zero, one, clock, counter</p> <p>Up to 2 MBit (2 levels)</p> <p>Up to 1 MSymbols (3 or 4 levels)</p> <p>1 bit</p> <p>4 bits</p> <p>< 2%</p>
<p>PRBS Pattern</p> <p>Max PRBS pattern rate</p> <p>Pattern levels</p> <p>PRBS types</p> <p>Overshoot (1 V_{p-p})</p>	<p>Up to 300 Mbaud</p> <p>2 levels</p> <p>PRBS -7,9,11,15,23,31</p> <p>< 2%</p>
<p>Pattern Modulation</p>	
<p>Amplitude Modulation (AM)</p> <p>Carrier patterns</p> <p>Modulation source</p> <p>Internal modulating waveforms</p> <p>Modulating frequency</p> <p>Depth</p>	<p>All types</p> <p>Internal or external</p> <p>Sine, Square, Triangular, Ramp_up, Ramp_down, DC, Sin(x)/x, Gaussian, Lorentz, Exponential Rise, Exponential Decay, Haversine, Noise, ARB</p> <p>Internal: 500 μHz to 48 MHz External: 8 MHz maximum</p> <p>0.00% to 120.00%</p>

<p>Frequency Modulation (FM)</p> <p>Carrier patterns</p> <p>Modulation source</p> <p>Internal modulating waveforms</p> <p>Modulating frequency</p> <p>Peak deviation</p>	<p>All types</p> <p>Internal or external</p> <p>Sine, Square, Triangular, Ramp_up, Ramp_down, DC, Sin(x)/x, Gaussian, Lorentz, Exponential Rise, Exponential Decay, Haversine, Noise, ARB</p> <p>Internal: 500 μHz to 48 MHz External: 8 MHz maximum</p> <p>DC to 300 MSymbols/s</p>
<p>Phase Modulation (PM)</p> <p>Carrier patterns</p> <p>Modulation source</p> <p>Internal modulating waveforms</p> <p>Modulating frequency</p> <p>Phase deviation range</p>	<p>All types</p> <p>Internal or external</p> <p>Sine, Square, Pulse, Ramp_up, Ramp_down, DC, Sin(x)/x, Gaussian, Lorentz, Exponential Rise, Exponential Decay, Haversine, Noise, ARB</p> <p>Internal: 500 μHz to 48 MHz External: 8 MHz maximum</p> <p>0° to 360°</p>
<p>Frequency Shift Keying (FSK)</p> <p>Carrier patterns</p> <p>Modulation source</p> <p>Internal modulating waveforms</p> <p>Key rate</p>	<p>All types</p> <p>Internal or external</p> <p>Square</p> <p>Internal: 500 μHz to 48 MHz External: 8 MHz maximum</p>

<p>Hope Symbol Rate</p> <p>Number of keys</p>	<p>1uSymbols/s to 300 MSymbols/s for Custom and PRBS pattern</p> <p>1uHz to 150 MHz for Clock pattern</p> <p>2</p>
<p>Phase Shift Keying (PSK)</p> <p>Carrier patterns</p> <p>Modulation source</p> <p>Internal modulating waveforms</p> <p>Key rate</p> <p>Hop phase</p> <p>Number of keys</p>	<p>All types</p> <p>Internal or external</p> <p>Square</p> <p>Internal: 500 μHz to 48 MHz, External: 8 MHz maximum</p> <p>0° to +360°</p> <p>2</p>
<p>Burst</p> <p>Patterns</p> <p>Type</p> <p>Burst count</p>	<p>All types</p> <p>Block mode or Bit mode</p> <p>1 to 4,294,967,295 cycles or Infinite</p>

**8 bit LVDS to LVTTTL Converter
Probe (Optional AT-DTLL8)**



Output connector	20 position 2.54 mm 2 Row IDC Header
Output type	LVTTL
Output impedance	50 Ω nominal
Output voltage	0.8V to 3.8V programmable in group of 8 bits
Maximum Update Rate	125 Mbps@0.8V and 400 Mbps@3.6V
Dimensions	W 52 mm – H 22 mm – D 76 mm
Input Connector	Proprietary standard
Cable Length	1 meter
Cable Type	Proprietary standard

Proprietary Mini SAS HD to SMA cable (Optional)


Output connector	SMA
Output type	LVDS
Number of SMA	16 (8 bits)
Cable type	Proprietary standard
Cable Length	1 meter

Auxiliary input and output characteristics

Marker Output	
Connector type	BNC on front panel
Number of connectors	1, 2 or 4
Output impedance	50 Ω
Output level (into 50 Ω)	
Amplitude	1 V to 2.5 V
Resolution	10 mV
Accuracy	$\pm(2\% \text{ setting} + 10 \text{ mV})$
Rise/fall time (10% to 90%, 2.5 V _{p-p})	< 700 ps
Jitter (rms)	20 ps

<p>Marker out to analog channel skew</p> <p>Range</p> <p>Resolution</p> <p>Accuracy</p> <p>Initial skew</p>	<p>AFG and DPG Mode: 0 to 14s in Continuous Mode</p> <p>0 to 3 us in Triggered Mode</p> <p>True Arb Mode: 0 to 3μs</p> <p>AFG and DPG Mode: 39 ps</p> <p>True Arb Mode: 78 ps,</p> <p>±(1% of setting + 140 ps)</p> <p>< 1 ns</p>
<p>Trigger/Gate Input</p> <p>Connector type</p> <p>Input impedance</p> <p>Slope/Polarity</p> <p>Input damage level</p> <p>Threshold control level</p> <p>Resolution</p> <p>Threshold control accuracy</p> <p>Input voltage swing</p> <p>Minimum pulse width (1 V_{p-p})</p> <p>Initial trigger delay to Analog Output</p> <p>Trigger In to output jitter</p> <p>Maximum Frequency</p>	<p>BNC on the Front Panel</p> <p>50Ω / 1kΩ</p> <p>Positive or negative or both</p> <p>< -15 V or > +15 V</p> <p>-10 V to 10 V</p> <p>50 mV</p> <p>±(10% of setting + 0.2 V)</p> <p>0.5 V_{p-p} minimum</p> <p>3 ns</p> <p>AFG: < 360 ns (< 420 ns in triggered sweep mode,AFG only)</p> <p>True Arb mode: < 240 * DAC clock period + 32 ns</p> <p>DPG mode: < 370 ns</p> <p>AFG and DPG mode: < 40 ps</p> <p>True Arb mode: 0.29*DAC clock period</p> <p>AFG and DPG mode: 65 MTps on Rising/Falling Edge</p>

	<p>80 MTps on Both Edges</p> <p>True Arb mode: 42.5 MTps</p> <p>where MTps = Mega Transitions per second</p>
Reference Clock Input	
Connector type	SMA on rear panel
Input impedance	50 Ω , AC coupled
Input voltage range	-4 dBm to 11 dBm sine or square wave (Rise time T10-90 < 1 ns and Duty Cycle from 40% to 60%)
Damage level	+14 dBm
Frequency range	5 MHz to 100 MHz
Reference Clock Output	
Connector type	SMA on rear panel
Output impedance	50 Ω , AC coupled
Frequency	10 MHz
Accuracy	\pm 2.0 ppm
Aging	\pm 1.0 ppm/year
Amplitude	1.65V
Jitter (rms)	< 20 ps
External Modulation Input	
Connector type	SMA on rear panel
Input impedance	>2 M Ω
Number of inputs	1
Bandwidth	8 MHz with 40 MS/s sampling rate
Input voltage range	-1V to +1V (open load)
Vertical resolution	8-bit

Power	
Source Voltage and Frequency	100 to 240 VAC ±10% @ 45-66 Hz
Maximum power consumption	150 W
Environmental characteristics	
Temperature (operating)	+5 °C to +40 °C (+41 °F to 104 °F)
Temperature (non-operating)	-20 °C to +60 °C (-4 °F to 140 °F)
Humidity (operating)	5% to 80% relative humidity with a maximum wet bulb temperature of 29°C at or below +40°C, (upper limit de-rates to 20.6% relative humidity at +40°C). Non-condensing.
Humidity (non-operating)	5% to 95% relative humidity with a maximum wet bulb temperature of 40°C at or below +60°C, upper limit de-rates to 29.8% relative humidity at +60°C. Non-condensing.
Altitude (operating)	3,000 meters (9,842 feet) maximum at or below 25°C
Altitude (non-operating)	12,000 meters (39,370 feet) maximum
EMC and safety	
Compliance	CE compliant
Safety	EN61010-1
Main Standards	EN 61326-1:2013 – Electrical equipment for measurement, control and laboratory use – EMC requirements – Part 1: General requirements
Immunity	EN 61326-1:2013
System specifications	
Display	7 inch, 1024x600, capacitive touch LCD
Operative System	Windows 10
External Dimensions	W 445 mm – H 135 mm – D 320 mm (3U 19" rackmount)
Weight	9.5Kg (AWG4012) – 10.3Kg (AWG4014) – 12Kg (AWG4018)

Front panel connectors	<p>CH1 to CH8 OUTPUT (BNC)</p> <p>MARKER OUT 1 to 4 (BNC)</p> <p>TRIGGER IN (BNC)</p> <p>2 USB 3.0 ports</p>
Rear panel connectors	<p>Ref Clk In (SMA)</p> <p>Ref Clk Out (SMA)</p> <p>Ext Mod In (SMA)</p> <p>External Monitor ports (one or more)</p> <p>DIGITAL POD A[7..0] (AWG 4012 / 4014 / 4018)</p> <p>DIGITAL POD B[7..0] (AWG 4014 / 4018)</p> <p>DIGITAL POD C[7..0] (AWG 4018)</p> <p>DIGITAL POD D[7..0] (AWG 4018)</p> <p>4 USB 3.0 ports</p> <p>Ethernet port (10/100/1000BaseT Ethernet, RJ45 port)</p> <p>2 PS/2 keyboard and mouse ports</p>
Hard Disk	<p>256 GB SSD</p>
Processor	<p>Intel® Pentium, 3.8 GHz</p>
Processor Memory	<p>8 GB</p>

Table of Available Models

Item	Description
AWG4012-2M	2ch 1.2 GS/s AWG 2MS memory - 300MHz AFG - 6Vpp
AWG4012-64M	2ch 1.2 GS/s AWG 64MS memory - 300MHz AFG - 6Vpp
AWG4012-128M	2ch 1.2 GS/s AWG 128MS memory - 300MHz AFG - 6Vpp
AWG4012-1G	2ch 1.2 GS/s AWG 1GS memory - 300MHz AFG - 6Vpp
AWG4014-2M	4ch 1.2 GS/s AWG 2MS memory - 300MHz AFG - 6Vpp
AWG4014-64M	4ch 1.2 GS/s AWG 64MS memory - 300MHz AFG - 6Vpp
AWG4014-128M	4ch 1.2 GS/s AWG 128MS memory - 300MHz AFG - 6Vpp
AWG4014-1G	4ch 1.2 GS/s AWG 1GS memory - 300MHz AFG - 6Vpp
AWG4018-2M	8ch 1.2 GS/s AWG 2MS memory - 300MHz AFG - 6Vpp
AWG4018-64M	8ch 1.2 GS/s AWG 64MS memory - 300MHz AFG - 6Vpp
AWG4018-128M	8ch 1.2 GS/s AWG 128MS memory - 300MHz AFG - 6Vpp
AWG4018-1G	8ch 1.2 GS/s AWG 1GS memory - 300MHz AFG - 6Vpp

Table of Available Options and Accessories

Item	Description
Options	
AWG-4012-HV	High voltage output (12Vpp on 50ohm) for AWG4012
AWG-4014-HV	High voltage output (12Vpp on 50ohm) for AWG4014
AWG-4018-HV	High voltage output (12Vpp on 50ohm) for AWG4018
AWG-4010-DIG8	8 channel Dig license (Mini SAS cable included) for AWG401x
AWG4012-WAR	3 years warranty extension for AWG4012
AWG4014-WAR	3 years warranty extension for AWG4014
AWG4018-WAR	3 years warranty extension for AWG4018
AWG4012-PAT	2ch Serial pattern generator option
AWG4014-PAT	4ch Serial pattern generator option
AWG4018-PAT	8ch Serial pattern generator option
Accessories	
AT-LVDS-SMA8	Mini SAS HD to 16 SMA cable (8 LVDS output)
AT-DTTL8	8 bit LVDS to LVTTTL converter for Rider series
RIDER-RACK	Rackmount kit for Rider series instruments (Pulse, Funct., Arb.)
RIDER-AWG-SYNC	Synchronization cable for AWG Rider series
GPIB / USB-TMC	GPIB and USBTMC Ports for Remote Control
SSD-250	Additional 250GB Solid State Disk for RIDER series
SSD-500	Additional 500GB Solid State Disk for RIDER series
SSD-1000	Additional 1TB Solid State Disk for RIDER series